

<b>Notice of References Cited</b>	Application/Control No. <b>09/904,709</b>	Applicant(s)/Patent Under Reexam <b>Burbank et al.</b>	
	Examiner <b>John Kim</b>	Art Unit <b>1723</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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	B	5,820,767	10/1998	Kane et al.	210	787
	C	4,784,768	11/1988	Mathieu	210	321.8
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		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
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**NON-PATENT DOCUMENTS**

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.